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N-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary (Typ.@ V_{GS} = 4.5V, T_A = +25°C)

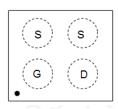
BV _{DSS}	R _{DS(ON)}	I _D
12V	38mΩ	4.0A

Description

This new generation MOSFET is engineered to minimize on-state losses and switch ultra-fast, making it ideal for high-efficiency power transfer. It uses Chip-Scale Package (CSP) to increase power density by combining low thermal impedance with minimal $R_{\rm DS(ON)}$ per footprint area.

Applications

- DC-DC Converters
- Battery Management
- Load Switch



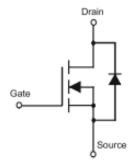
Top-View Pin Configuration

Features

- TR-MOS Technology with the Lowest R_{DS(ON)}
- CSP with Footprint 0.81mm × 0.81mm (Typ.)
- Height = 0.29mm for Low Profile
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: X3-DSN0808-4
- Terminal Connections: See Diagram Below
- Terminal Finish: Matte Tin Annealed Over Copper Pillar (3)
- UBM: 203µm



Equivalent Circuit

Ordering Information (Note 4)

Part Number	Case	Packaging
DMN1053UCP4-7	X3-DSN0808-4	3,000/Tape & Reel

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information

4B YM 4B = Product Type Marking Code YM = Date Code Marking Y or \overline{Y} = Year (ex: E = 2017) M or \overline{M} = Month (ex: 9 = September)

Date Code Key

Year	201	6	2017		2018	20	19	2020		2021	2	2022
Code	D		E		F	(G	Н				J
Month	Jan	Feb	Mar	Apr	May	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings

Characteristic	Symbol	Value	Unit	
Drain-Source Voltage	V_{DSS}	12	V	
Gate-Source Voltage	V _{GSS}	±8	V	
Continuous Source Current @ V _{GS} = 4.5V (Note 5)	$T_A = +25$ °C $T_A = +70$ °C	I _D	2.7 2.2	А
Continuous Source Current @ V _{GS} = 4.5V (Note 6)	I _D	4.0 3.2	А	
Pulsed Drain Current (Pulse Duration 10µs, Duty Cycle ≤19	I _{DM}	8	Α	
Continuous Source-Drain Diode Current	I _S	0.74	Α	
Pulse Diode Forward Current	I _{SM}	15	A	

Thermal Characteristics

Characteristic	Symbol	Value	Unit
Total Power Dissipation (Note 5)	P_{D}	0.74	W
Thermal Resistance, Junction to Ambient (Note 5)	$R_{\theta JA}$	167	°C/W
Total Power Dissipation (Note 6)	P _D	1.34	W
Thermal Resistance, Junction to Ambient (Note 6)	$R_{\theta JA}$	93	°C/W
Operating and Storage Temperature Range	$T_{J_1}T_{STG}$	-55 to +150	°C

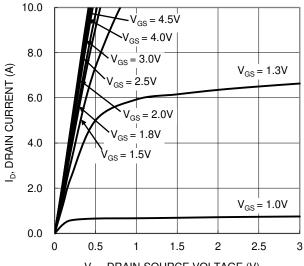
Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition			
OFF CHARACTERISTICS (Note 7)									
Drain-Source Breakdown Voltage	BV _{DSS}	12	-	-	V	$V_{GS} = 0V, I_D = 250\mu A$			
Zero Gate Voltage Drain Current	I _{DSS}	1	i	1.0	μΑ	$V_{DS} = 9.6V, V_{GS} = 0V$			
Gate-Body Leakage	I_{GSS}	1	ı	±100	nA	$V_{GS} = \pm 8V, V_{DS} = 0V$			
ON CHARACTERISTICS (Note 7)									
Gate Threshold Voltage	$V_{GS(TH)}$	0.35	0.5	0.7	٧	$V_{DS} = V_{GS}, I_D = 250 \mu A$			
Static Drain-Source On-Resistance	R _{DS(ON)}	ı	38 42 45 49 57 82	42 50 53 65 80 110	mΩ	$\begin{split} V_{GS} &= 4.5 \text{V, } I_D = 1.0 \text{A} \\ V_{GS} &= 2.5 \text{V, } I_D = 1.0 \text{A} \\ V_{GS} &= 2.1 \text{V, } I_D = 1.0 \text{A} \\ V_{GS} &= 1.8 \text{V, } I_D = 0.5 \text{A} \\ V_{GS} &= 1.5 \text{V, } I_D = 0.2 \text{A} \\ V_{GS} &= 1.2 \text{V, } I_D = 0.1 \text{A} \end{split}$			
Forward Transfer Admittance	Y _{fs}	-	6.0	-	S	$V_{DS} = 6V, I_{S} = 1.0A$			
Body Diode Forward Voltage	V_{SD}	-	0.7	1	V	$V_{GS} = 0V, I_{S} = 1.0A$			
DYNAMIC CHARACTERISTICS (Note 8)									
Input Capacitance	C_{iss}	-	612	908	pF	$V_{DS} = 6V, V_{GS} = 0V,$			
Output Capacitance	Coss	-	91	127	pF	-f = 1.0MHz			
Reverse Transfer Capacitance	C_{rss}	-	84	126	pF				
Gate Resistance	R_g	-	1.3	2.6	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$			
Total Gate Charge	Q_g	-	7.2	15	nC	V 45V V 6V			
Gate-Source Charge	Q_{gs}	-	0.6	-	nC	$V_{GS} = 4.5V, V_{DS} = 6V,$ $I_{D} = 1.0A$			
Gate-Drain Charge	Q_gd	-	1.3	-	nC	ID = 1.0A			
Turn-On Delay Time	t _{D(ON)}	-	3.6	10	ns				
Turn-On Rise Time	t _R	-	6.0	14	ns	$V_{DD} = 6V, I_{D} = 1.0A$			
Turn-Off Delay Time	t _{D(OFF)}	-	13.5	32	ns	$V_{GEN}=4.5V,\ R_{G}=1\Omega,\ R_{L}=6\Omega$			
Turn-Off Fall Time	t _F	-	2	4	ns				
Reverse Recovery Charge	Q _{RR}	-	0.7	1.5	nC	I _F = 1A, di/dt = 100A/µs			
Body Diode Reverse Recovery Time	t _{RR}	-	6.4	14	ns	IF = 1A, αι/αι = 100A/μS			

Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.
Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
Short duration pulse test used to minimize self-heating effect.

^{8.} Guaranteed by design. Not subject to production testing.





V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 1. Typical Output Characteristic

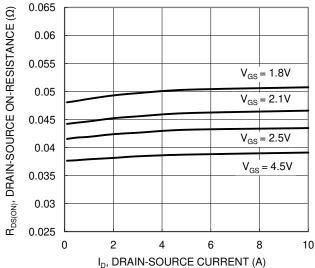


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

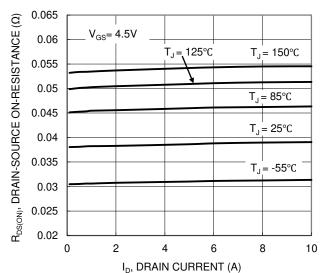
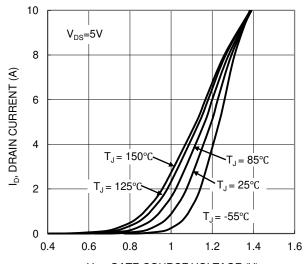
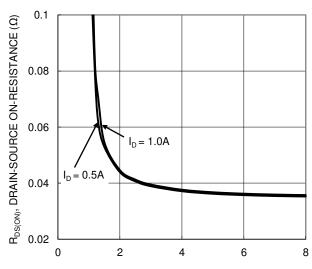


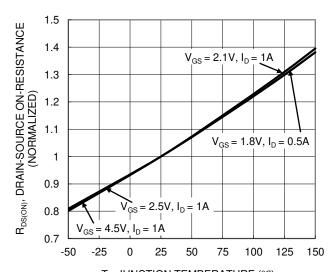
Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic



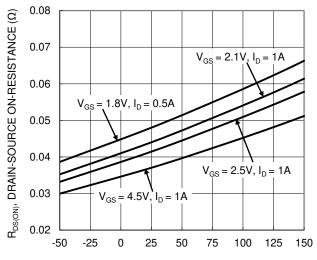
V_{GS}, GATE-SOURCE VOLTAGE (V) Figure 4. Typical Transfer Characteristic



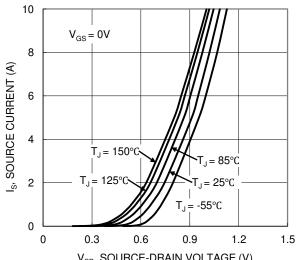
T_J, JUNCTION TEMPERATURE (°C) Figure 6. On-Resistance Variation with Junction Temperature

DMN1053UCP4





T_J, JUNCTION TEMPERATURE (°C) Figure 7. On-Resistance Variation with Junction Temperature



V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current

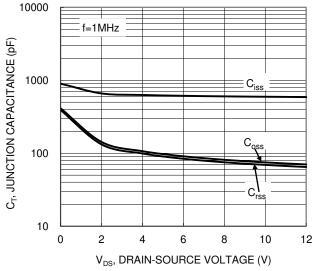
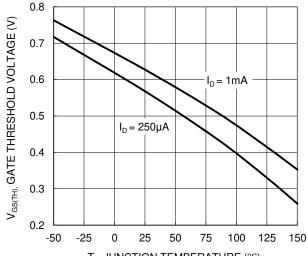
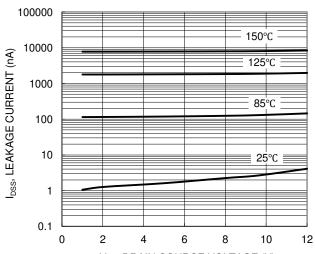


Figure 11. Typical Junction Capacitance



T_J, JUNCTION TEMPERATURE (°C) Figure 8. Gate Threshold Variation vs. Junction Temperature



V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 10. Typical Drain-Source Leakage Current vs. Voltage

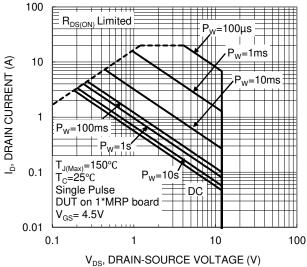


Figure 12. SOA, Safe Operation Area



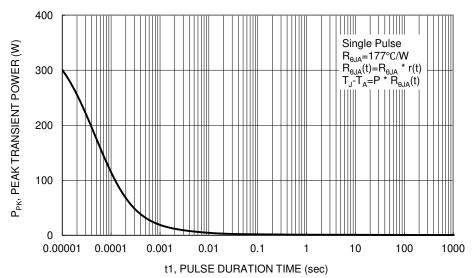


Figure 13. Single Pulse Maximum Power Dissipation

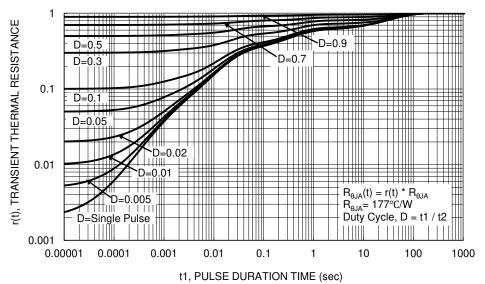


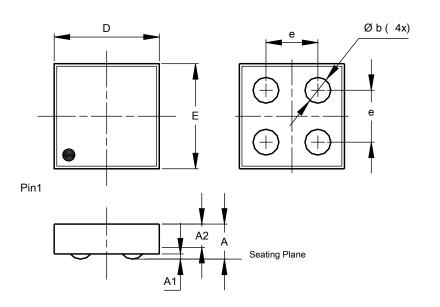
Figure 14. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

X3-DSN0808-4

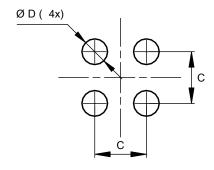


X3-DSN0808-4						
Dim	Min	Max	Тур			
Α	0.2510	0.2890	0.2700			
A 1	0.0360	0.0440	0.0400			
A2	0.2150	0.2450	0.2300			
b	0.1836	0.2244	0.2040			
D	0.7900	0.8300	0.810			
Е	0.7900	0.8300	0.810			
е	-	-	0.400			
All Dimensions in mm						

Suggested Pad Layout

 $Please \ see \ http://www.diodes.com/package-outlines.html \ for \ the \ latest \ version.$

X3-DSN0808-4



Dimensions	Value (in mm)			
С	0.400			
D	0.2040			



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